

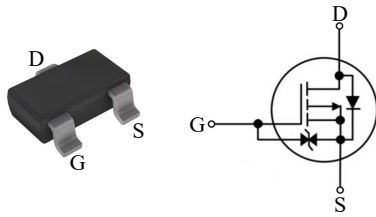


SM06P7KTDSH

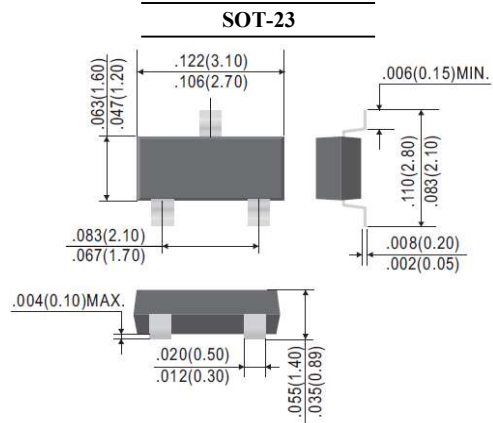
P-Channel Enhancement Mode Field Effect Transistor

FEATURES

- ESD protected gate > 1kV (HBM)
- Suffix "H" indicates Halogen-free parts, ex. SM06P7KTDSH



| PIN | Description |
|-----|-------------|
| G | Gate |
| S | Source |
| D | Drain |



Dimensions in inches and (millimeters)

Maximum Ratings ($T_A = 25^\circ\text{C}$ unless otherwise noted)

| Parameter | Symbol | Value | Unit |
|--|-----------------|---------------|---------------------------|
| Drain-Source Voltage | V_{DSS} | -60 | V |
| Gate-Source Voltage | V_{GSS} | ± 20 | V |
| Continuous Drain Current | I_D | -0.2 | A |
| Pulsed Drain Current (Note 1) | I_{DM} | -1.2 | A |
| Power Dissipation (Note 2) | P_D | 0.5 | W |
| Thermal Resistance from Junction to Ambient (Note 2) | $R_{\theta JA}$ | 250 | $^\circ\text{C}/\text{W}$ |
| Operating and Storage Temperature Range | T_J, T_{stg} | - 55 to + 150 | $^\circ\text{C}$ |

Note :

1. Pulse width $\leq 100\mu\text{s}$, Duty cycle $\leq 2\%$, Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)} = 150^\circ\text{C}$
2. The value of $R_{\theta JA}$ is measured with device mounted on 1 in² FR-4 board with 2oz copper, in a still air environment with $T_A = 25^\circ\text{C}$. The value in any given application depends on the user's specific board design. The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.



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Electrical Characteristics ($T_A = 25\text{ }^\circ\text{C}$ unless otherwise specified)

| Parameter | Conditions | Symbol | Min. | Typ. | Max. | Unit |
|------------------------------------|---|--------------|------|------|----------|---------------|
| Static | | | | | | |
| Drain Source Breakdown Voltage | $I_D = -250\mu\text{A}$ | BV_{DSS} | -60 | - | - | V |
| Zero Gate Voltage Drain Current | $V_{DS} = -48\text{V}$ | I_{DSS} | - | - | -1 | μA |
| Gate-Body Leakage Current | $V_{GS} = \pm 20\text{V}$ | I_{GSS} | - | - | ± 10 | μA |
| Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = -250\mu\text{A}$ | $V_{GS(th)}$ | -0.8 | - | -2.0 | V |
| Static Drain Source On-Resistance | $V_{GS} = -10\text{V}, I_D = -0.2\text{A}$ $V_{GS} = -4.5\text{V}, I_D = -0.1\text{A}$ | $R_{DS(on)}$ | - | - | 6 | Ω |
| | | | - | - | 7 | |
| Forward Transconductance | $V_{DS} = -25\text{V}, I_D = -0.1\text{A}$ | g_{FS} | - | 289 | - | mS |
| Dynamic | | | | | | |
| Gate Resistance | $V_{DS} = 0, V_{GS} = 0, f = 1\text{MHz}$ | R_g | - | 21 | - | Ω |
| Total Gate Charge | $V_{DS} = -25\text{V}, I_D = -0.1\text{A}, V_{GS} = -4.5\text{V}$ | Q_g | - | 1.1 | - | nC |
| Gate-Source Charge | | Q_{gs} | - | 0.3 | - | |
| Gate-Drain Charge | | Q_{gd} | - | 0.2 | - | |
| Input Capacitance | $V_{DS} = -30\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$ | C_{iss} | - | 38 | - | pF |
| Output Capacitance | | C_{oss} | - | 9 | - | |
| Reverse Transfer Capacitance | | C_{rss} | - | 6 | - | |
| Turn-On Delay Time | $V_{DD} = -25\text{V}, V_{GS} = -10\text{V}, I_D = 0.1\text{A}\Omega,$ $R_g = 6.8\Omega$ | $t_{d(on)}$ | - | 14 | - | ns |
| Turn-On Rise Time | | t_r | - | 4 | - | |
| Turn-Off Delay Time | | $t_{d(off)}$ | - | 15 | - | |
| Turn-Off Fall Time | | t_f | - | 77 | - | |
| Drain-Source Body Diode | | | | | | |
| Drain-Source Diode Forward Voltage | $I_S = -0.5\text{A}$ | V_{SD} | - | - | -1.3 | V |
| Reverse Recovery Time | $I_S = -0.1\text{A}, di/dt = 100\text{A}/\mu\text{s}$ | t_{rr} | - | 60 | - | ns |
| Reverse Recovery Charge | | Q_{rr} | - | 58 | - | nC |



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RATINGS AND CHARACTERISTIC CURVES

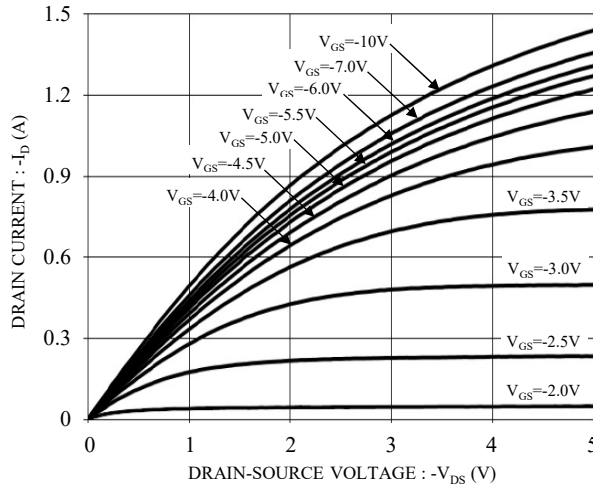


Fig.1 Typical Output Characteristics

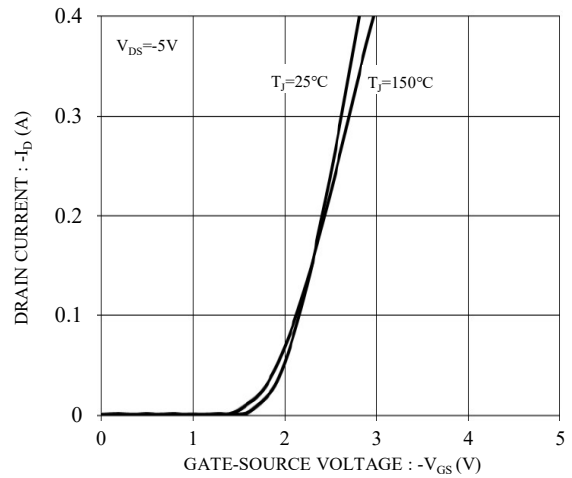


Fig.2 Typical Transfer Characteristics

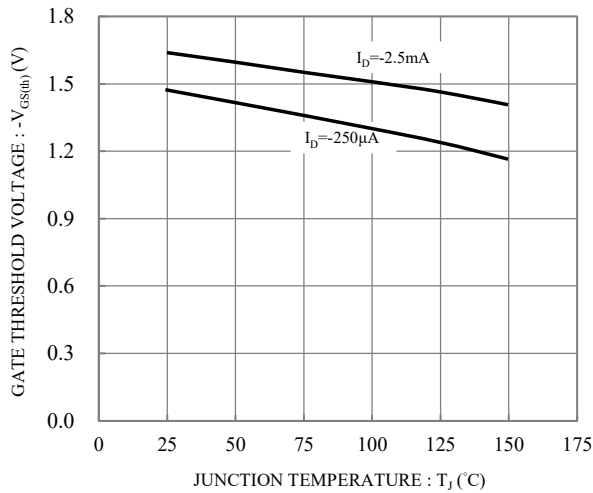


Fig.3 Gate Threshold Voltage vs. Junction Temperature

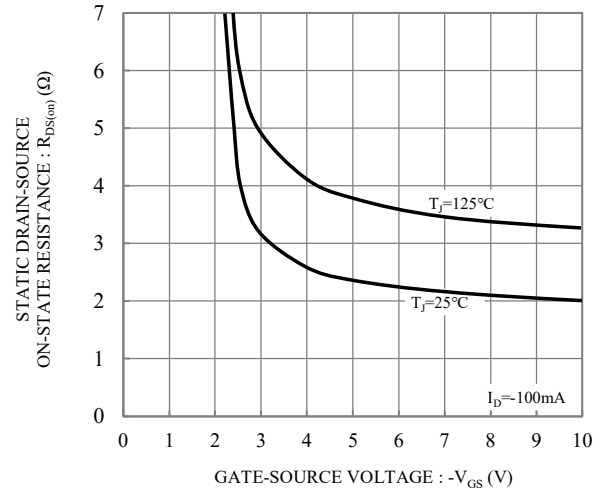


Fig.4 Static Drain-Source On-State Resistance vs. Gate-Source Voltage

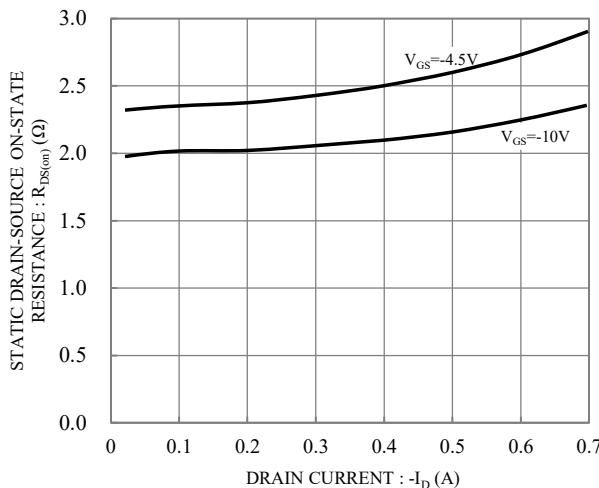


Fig.5 Static Drain-Source On-State Resistance vs. Drain Current

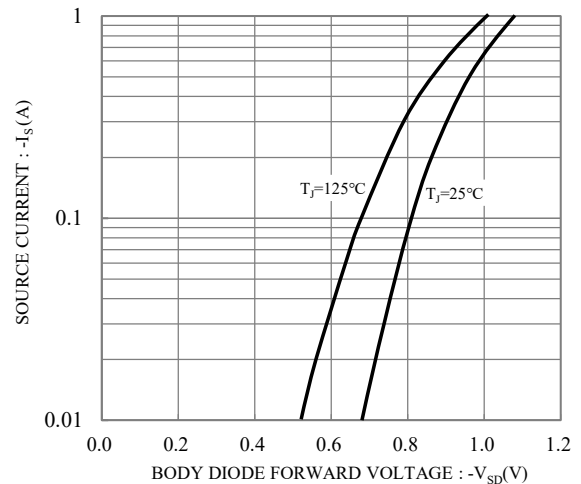


Fig.6 Body Diode Forward Voltage vs. Source Current



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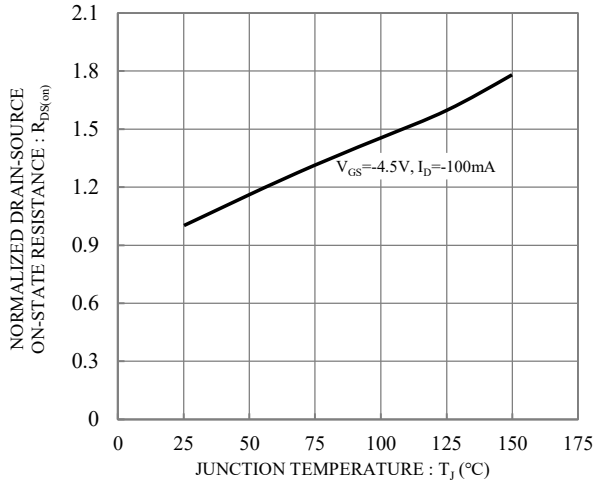


Fig.7 Drain-Source On-State Resistance vs. Junction Temperature

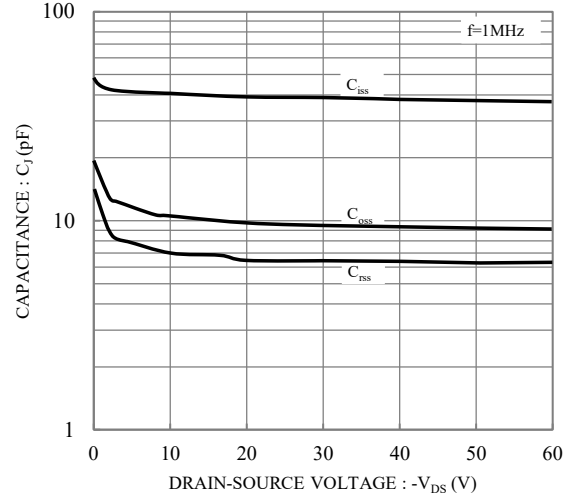


Fig.8 Capacitance vs. Drain-Source Voltage

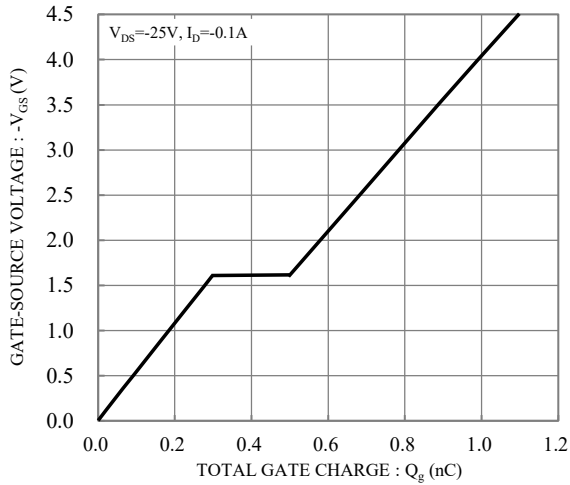


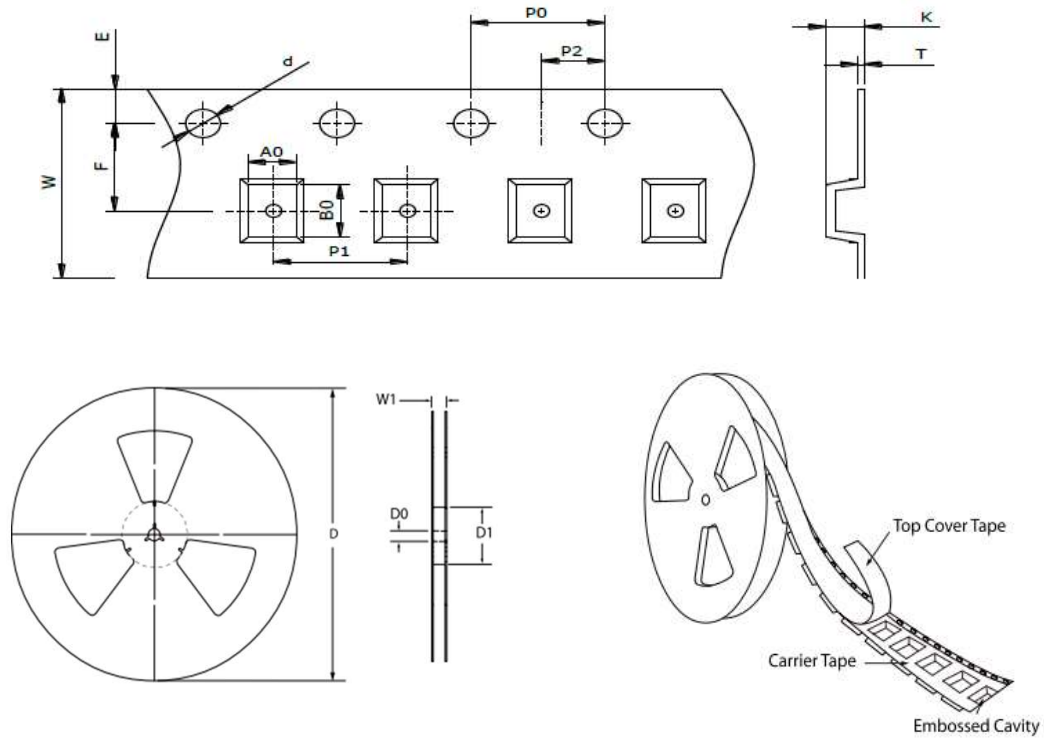
Fig.9 Gate Charge Characteristics



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TAPE & REEL SPECIFICATION



| Item | Symbol | SOT-23 |
|------------------------|--------|-------------------|
| Carrier width | A_0 | 3.30 ± 0.10 |
| Carrier length | B_0 | 3.00 ± 0.10 |
| Carrier depth | K | 1.70 ± 0.10 |
| Sprocket hole | d | 1.50 ± 0.10 |
| Reel outside diameter | D | 178.00 ± 2.00 |
| Feed hole width | D_0 | 13.00 ± 0.50 |
| Reel inner diameter | D_1 | MIN. 50.00 |
| Sprocket hole position | E | 1.75 ± 0.10 |
| Punch hole position | F | 3.50 ± 0.10 |
| Sprocket hole pitch | P_0 | 4.00 ± 0.10 |
| Punch hole pitch | P_1 | 4.00 ± 0.10 |
| Embossment center | P_2 | 2.00 ± 0.10 |
| Overall tape thickness | T | 0.20 ± 0.05 |
| Tape width | W | 8.00 ± 0.20 |
| Reel width | W1 | MAX. 14.50 |

ORDER INFORMATION

| Package | Reel Size | Quantity |
|---------|-----------|----------|
| SOT-23 | 7" | 3,000 |

MARKING CODE

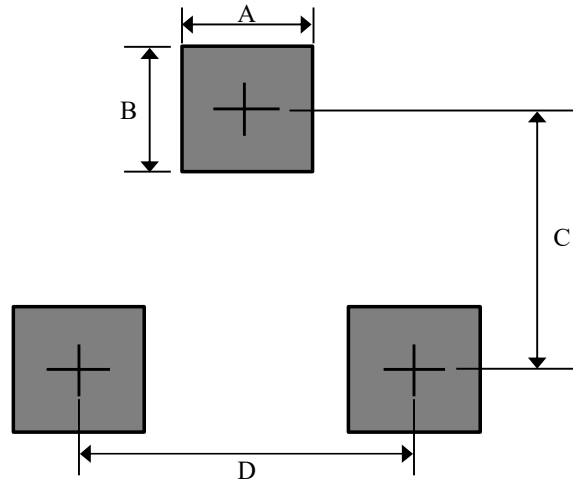
| Part Number | Marking Code |
|-------------|--------------|
| SM06P7KTDSH | XS |



SM06P7KTDSH

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SUGGESTED SOLDER PAD LAYOUT



Unit : mm

| PACKAGE | A | B | C | D |
|---------|------|------|------|------|
| SOT-23 | 0.80 | 1.00 | 2.40 | 1.90 |